

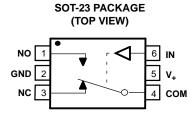
#### **FEATURES**

- Controlled Baseline
  - One Assembly/Test Site, One Fabrication Site
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree (1)
- Specified Break-Before-Make Switching
- Low ON-State Resistance (1  $\Omega$ )
- Control Inputs Are 5-V Tolerant
- Low Charge Injection
- Excellent ON-State Resistance Matching
- (1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not liited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Low Total Harmonic Distortion
- 1.65-V to 5.5-V Single-Supply Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)

#### **APPLICATIONS**

- Cell Phones
- PDAs
- Portable Instrumentation



#### **DESCRIPTION/ORDERING INFORMATION**

The TS5A3159-EP is a single-pole double-throw (SPDT) analog switch that is designed to operate from 1.65 V to 5.5 V. The device offers a low ON-state resistance and an excellent ON-state resistance matching with the break-before-make feature to prevent signal distortion during the transferring of a signal from one channel to another. The device has excellent total harmonic distortion (THD) performance and consumes very low power. These features make this device suitable for portable audio applications.

#### Summary of Characteristics(1)

Configuration	2:1 Multiplexer/ Demultiplexer (1 × SPDT)
Number of channels	1
ON-state resistance (r <sub>on</sub> )	1.1 Ω
ON-state resistance match (Δr <sub>on</sub> )	0.1 Ω
ON-state resistance flatness (r <sub>on(flat)</sub> )	0.15 Ω
Turn-on/turn-off time (t <sub>ON</sub> /t <sub>OFF</sub> )	20 ns/15 ns
Break-before-make time (t <sub>BBM</sub> )	12 ns
Charge injection (Q <sub>C</sub> )	36 pC
Bandwidth (BW)	100 MHz
OFF isolation (O <sub>ISO</sub> )	-65 dB at 1 MHz
Crosstalk (X <sub>TALK</sub> )	-66 dB at 1 MHz
Total harmonic distortion (THD)	0.01%
Leakage current (I <sub>NO(OFF)</sub> /(I <sub>NC(OFF)</sub> )	±20 nA
Package option	6-pin DBV

(1)  $V_+ = 5 \text{ V} \text{ and } T_A = 25^{\circ}\text{C}$ 



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



#### **ORDERING INFORMATION**

T <sub>A</sub>	PACKAG	SE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
–55°C to 125°C	SOT (SOT-23) - DBV	Tape and reel	TS5A3159MDBVREP	JA8R		

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

#### **FUNCTION TABLE**

IN	NC TO COM, COM TO NC	NO TO COM, COM TO NO
L	ON	OFF
Н	OFF	ON

## Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>+</sub>	Supply voltage range <sup>(2)</sup>		-0.5	6.5	V
$V_{NO} \ V_{COM}$	Analog voltage range <sup>(2)(3)(4)</sup>		-0.5	V <sub>+</sub> + 0.5	V
I <sub>I/OK</sub>	Analog port diode current	$V_{NO}$ , $V_{COM} < 0$ or $V_{NO}$ , $V_{COM} > V_{+}$		±50	mA
I <sub>NO</sub> I <sub>COM</sub>	On-state switch current	$V_{NO}$ , $V_{COM} = 0$ to $V_{+}$		±200	mA
	On-state peak switch current <sup>(5)</sup>			±400	mA
$V_{IN}$	Digital input voltage range(2)(3)		-0.5	6.5	V
I <sub>IK</sub>	Digital input clamp current	V <sub>IN</sub> < 0		-50	mA
	Continuous current through V <sub>+</sub> or GND			±100	mA
$\theta_{JA}$	Package thermal impedance (6)			165	°C/W
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Electrical Characteristics" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground, unless otherwise specified.

<sup>(3)</sup> The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>(4)</sup> This value is limited to 5.5 V maximum.

<sup>(5)</sup> Pulse at 1-ms duration < 10% duty cycle.

<sup>(6)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.



# **Electrical Characteristics for 5-V Supply**

 $V_{+} = 4.5 \text{ V to } 5.5 \text{ V (5 V nominal)}, T_{A} = -55^{\circ}\text{C to } 125^{\circ}\text{C} \text{ (unless otherwise noted)}$ 

PARAMETER	SYMBOL	TEST CONDI	TIONS	T <sub>A</sub>	V <sub>+</sub>	MIN T	YP <sup>(1)</sup>	MAX	UNIT
<b>Analog Switch</b>									
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0		V <sub>+</sub>	V
Peak ON		$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	4.5 V		1	1.5	Ω
resistance	r <sub>peak</sub>	$I_{COM} = -30 \text{ mA},$	See Figure 11	Full	4.5 V			1.5	52
ON-state	r	$V_{NO}$ or $V_{NC} = 2.5 \text{ V}$ ,	Switch ON,	25°C	4.5 V		0.75	1.1	Ω
resistance	r <sub>on</sub>	$I_{COM} = -30 \text{ mA},$	See Figure 11	Full	4.5 V			1.3	52
ON-state resistance match between channels	$\Delta { m r}_{ m on}$	$V_{NO}$ or $V_{NC}$ = 2.5 V, $I_{COM}$ = -30 mA,	Switch ON, See Figure 11	25°C	4.5 V		0.1		Ω
ON-state		$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -30 \text{ mA}$	Switch ON,		4.5 V	(	0.233		Ω
resistance flatness	r <sub>on(flat)</sub>	$V_{NO}$ or $V_{NC} = 1 \text{ V}$ , 1.5 V, 2.5 V, $I_{COM} = -30 \text{ mA}$	See Figure 11	25°C			0.15		
NC, NO	I <sub>NC(OFF)</sub> ,	$V_{NC}$ or $V_{NO} = 4.5 \text{ V}$ ,	Switch OFF,	25°C		-6	0.2	4	nA
OFF leakage current	I <sub>NO(OFF)</sub>	$V_{COM} = 0$ ,	See Figure 12	Full	5.5 V	-20		60	
NC, NO	I <sub>NC(ON)</sub> ,	$V_{NC}$ or $V_{NO} = 4.5 \text{ V}$ ,	Switch ON,	25°C	,	-6	2.8	4	
ON leakage current	I <sub>NO(ON)</sub>	V <sub>COM</sub> = Open,	See Figure 13	Full	5.5 V	-40		70	nA
СОМ		$V_{NC}$ or $V_{NO} = 4.5 \text{ V or Open}$ ,	Switch ON.	25°C		-4	0.47	7	_
ON leakage current	I <sub>COM(ON)</sub>	$V_{COM} = 4.5 \text{ V},$	See Figure 13	Full	5.5 V	-40		80	nA
<b>Digital Control</b>	Input (IN)								
Input logic high	$V_{IH}$			Full		2.4		5.5	٧
Input logic low	$V_{IL}$			Full		0		8.0	V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	5.5 V	-1		1	μΑ

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



## **Electrical Characteristics for 5-V Supply (continued)**

 $V_{+}$  = 4.5 V to 5.5 V (5 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CO	NDITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN TYP(1)	MAX	UNIT
Dynamic								
Turn-on time	t <sub>ON</sub>	$V_{COM} = V_+,$ $R_L = 50 \Omega,$	$C_L = 35 \text{ pF},$ See Figure 15	25°C Full	4.5 V to 5.5 V	20	35 40	ns
Turn-off time	t <sub>OFF</sub>	$V_{COM} = V_+,$ $R_L = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 15	25°C Full	4.5 V to 5.5 V	15	20 35	ns
Break-before- make time	t <sub>BBM</sub>	$V_{NC} = V_{NO} = V_{+}/2,$ $R_{L} = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 16	25°C Full	4.5 V to 5.5 V	1 12 1	14.5	ns
Charge injection	$Q_{\mathbb{C}}$	C <sub>L</sub> = 1 nF, V <sub>GEN</sub> = 0 V,	See Figure 20	25°C	5 V	36		рС
NC, NO OFF capacitance	$\begin{array}{c} C_{NC(OFF)}, \\ C_{NO(OFF)} \end{array}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	5 V	23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	5 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	5 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	5 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	5 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	5 V	-65		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	5 V	-65		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	5 V	0.01		%
Supply				•				
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+} \text{ or GND},$	Switch ON or OFF	Full	5.5 V		0.1	μΑ

TS5A3159-EP



# **Electrical Characteristics for 3.3-V Supply**

 $V_{+} = 3 \text{ V to } 3.6 \text{ V (3.3 V nominal)}, T_{A} = -55^{\circ}\text{C to } 125^{\circ}\text{C (unless otherwise noted)}$ 

PARAMETER	SYMBOL	TEST CONI	DITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
Analog Switch								<u> </u>	
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0		V <sub>+</sub>	V
Peak ON	r <sub>peak</sub>	$0 \le V_{NO} \text{ or } V_{NC} \le V_+,$	Switch ON,	25°C	3 V		1.35	2.15	Ω
resistance	poun	$I_{COM} = -24 \text{ mA},$	See Figure 11	Full				2.15	
ON-state	r <sub>on</sub>	$V_{NO}$ or $V_{NC} = 2 V$ ,	Switch ON,	25°C	3 V		1.15	1.7	Ω
resistance	OII	$I_{COM} = -24 \text{ mA},$	See Figure 11	Full				1.7	
ON-state resistance match between channels	$\Delta r_{\sf on}$	$V_{NO}$ or $V_{NC} = 2 \text{ V}$ , 0.8 V, $I_{COM} = -24 \text{ mA}$ ,	Switch ON, See Figure 11	25°C	3 V		0.11		Ω
ON-state resistance	r	$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -24$ mA	Switch ON,	25°C	3 V		0.225		Ω
flatness	r <sub>on(flat)</sub>	$V_{NO}$ or $V_{NC}$ = 2 V, 0.8 V, $I_{COM}$ = -24 mA	See Figure 11	25 0			0.25		
NC, NO OFF leakage current	I <sub>NC(OFF)</sub> , I <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = 3 V$ , $V_{COM} = 0$ ,	Switch OFF, See Figure 12	25°C	3.6 V		0.2		nA
NC, NO ON leakage current	I <sub>NC(ON)</sub> , I <sub>NO(ON)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = 3 V, V <sub>COM</sub> = Open,	Switch ON, See Figure 13	25°C	3.6 V		2.8		nA
COM ON leakage current	I <sub>COM(ON)</sub>	$V_{NC}$ or $V_{NO} = 3$ V or Open, $V_{COM} = 3$ V,	Switch ON, See Figure 13	25°C	3.6 V		0.47		nA
Digital Control I	nput (IN)			<u> </u>					
Input logic high	V <sub>IH</sub>			Full		2		5.5	V
Input logic low	V <sub>IL</sub>			Full		0	0.6		V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	3.6 V	-1		1	μΑ

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



## **Electrical Characteristics for 3.3-V Supply (continued)**

 $V_{+} = 3 \text{ V to } 3.6 \text{ V (}3.3 \text{ V nominal)}, T_{A} = -55^{\circ}\text{C to } 125^{\circ}\text{C (unless otherwise noted)}$ 

PARAMETER	SYMBOL	TEST CON	DITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN TYP(1)	MAX	UNIT
Dynamic								
Turn-on time	t <sub>ON</sub>	$V_{COM} = V_+,$ $R_1 = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 15	25°C Full	3 V to 3.6 V	30	40 55	ns
Turn-off time	t <sub>OFF</sub>	$V_{COM} = V_+,$	C <sub>L</sub> = 35 pF,	25°C	3 V to	20	25	ns
	011	$R_L = 50 \Omega$ ,	See Figure 15	Full	3.6 V		40	
Break-before- make time	t <sub>BBM</sub>	$\begin{aligned} V_{NC} &= V_{NO} = V_{+}/2, \\ R_{L} &= 50 \ \Omega, \end{aligned}$	$C_L = 35 pF$ , See Figure 16	25°C Full	3 V to 3.6 V	1 21	29	ns
Charge injection	$Q_{C}$	C <sub>L</sub> = 1 nF, V <sub>GEN</sub> = 0 V,	See Figure 20	25°C	3.3 V	20		рС
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = V <sub>+</sub> or GND, Switch OFF,	See Figure 14	25°C	3.3 V	23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	3.3 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	3.3 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	3.3 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	3.3 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	3.3 V	-65		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	3.3 V	-65		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	3.3 V	0.015		%
Supply				•				
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	3.6 V		0.1	μΑ

TS5A3159-EP



## **Electrical Characteristics for 2.5-V Supply**

 $V_{+}$  = 2.3 V to 2.7 V (2.5 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST COND	ITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
Analog Switch									
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0		V <sub>+</sub>	V
Peak ON	r .	$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	2.5 V		1.7	2.7	Ω
resistance	r <sub>peak</sub>	$I_{COM} = -8 \text{ mA},$	See Figure 11	Full	2.5 V			2.9	22
ON-state	r <sub>on</sub>	$V_{NO}$ or $V_{NC} = 1.8 \text{ V}$ ,	Switch ON,	25°C	2.5 V		1.45	2.3	Ω
resistance	'on	$I_{COM} = -8 \text{ mA},$	See Figure 11	Full	2.5 V			2.5	22
ON-state resistance match between channels	$\Delta r_{\sf on}$	$V_{NO}$ or $V_{NC}$ = 0.8 V, 1.8 V, $I_{COM}$ = -8 mA,	Switch ON, See Figure 11	25°C	2.5 V		0.7		Ω
ON-state resistance	_	$0 \le V_{NO} \text{ or } V_{NC} \le V_+,$ $I_{COM} = -8 \text{ mA}$	Switch ON,	25°C	2.5 V		0.5		Ω
flatness	r <sub>on(flat)</sub>	$V_{NO}$ or $V_{NC}$ = 0.8 V, 1.8 V, $I_{COM}$ = -8 mA	See Figure 11		O 2.5 V		0.45		
NC, NO OFF leakage current	I <sub>NC(OFF)</sub> , I <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = 2.3 \text{ V}$ , $V_{COM} = 0$ ,	Switch OFF, See Figure 12	25°C	2.7 V		0.2		nA
NC, NO ON leakage current	I <sub>NC(ON)</sub> , I <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = 2.3 \text{ V}$ , $V_{COM} = \text{Open}$ ,	Switch ON, See Figure 13	25°C	2.7 V		2.8		nA
COM ON leakage current	I <sub>COM(ON)</sub>	$V_{NC}$ or $V_{NO}$ = 2.3 V or Open, $V_{COM}$ = 2.3 V,	Switch ON, See Figure 13	25°C	2.7 V		0.47		nA
Digital Control II	nput (IN)								
Input logic high	V <sub>IH</sub>			Full		1.8		5.5	V
Input logic low	V <sub>IL</sub>			Full		0	0.6		V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	2.7 V	-1		1	μΑ

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



## **Electrical Characteristics for 2.5-V Supply (continued)**

 $V_{+}$  = 2.3 V to 2.7 V (2.5 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CON	DITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN TYP(1)	MAX	UNIT
Dynamic								
Turn-on time	+	$V_{COM} = V_+,$	C <sub>L</sub> = 35 pF,	25°C	2.3 V to	40	55	ns
rum-on ume	t <sub>ON</sub>	$R_L = 50 \Omega$ ,	See Figure 15	Full	2.7 V		70	115
Turn-off time	t <sub>OFF</sub>	$V_{COM} = V_+,$	$C_L = 35 \text{ pF},$	25°C	2.3 V to	30	40	ns
	OFF	$R_L = 50 \Omega$ ,	See Figure 15	Full	2.7 V		55	
Break-before-	t <sub>BBM</sub>	$V_{NC} = V_{NO} = V_{+}/2,$	$C_L = 35 \text{ pF},$	25°C	2.3 V to	1 33	39	ns
make time	DDIVI	$R_L = 50 \Omega$ ,	See Figure 16	Full	2.7 V	1		
Charge injection	$Q_{\mathbb{C}}$	$C_L = 1 \text{ nF},$ $V_{GEN} = 0 \text{ V},$	See Figure 20	25°C	2.5 V	13		pC
NC, NO OFF capacitance	$C_{NC(OFF)}$ , $C_{NO(OFF)}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	2.5 V	23		pF
NC, NO ON capacitance	$C_{NC(ON)}$ , $C_{NO(ON)}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	2.5 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	2.5 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	2.5 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	2.5 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	2.5 V	-64		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	2.5 V	-64		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	2.5 V	0.025		%
Supply							·	
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	2.7 V		0.1	μΑ

TS5A3159-EP



## **Electrical Characteristics for 1.8-V Supply**

 $V_{+}$  = 1.65 V to 1.95 V (1.8 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONI	DITIONS	T <sub>A</sub>	V <sub>+</sub>	MIN TYP <sup>(1)</sup>	MAX	UNIT
Analog Switch								
Analog signal range	$V_{COM}$ , $V_{NC}$ , $V_{NO}$					0	V <sub>+</sub>	V
Peak ON	r .	$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	1.8 V	4	4.9	Ω
resistance	r <sub>peak</sub>	$I_{COM} = -2 \text{ mA},$	See Figure 11	Full	1.0 V	7		22
ON-state	r <sub>on</sub>	$V_{NO}$ or $V_{NC} = 1.5 V$ ,	Switch ON,	25°C	1.8 V	1.7	3.2	Ω
resistance	on	$I_{COM} = -2 \text{ mA},$	See Figure 11	Full	1.0 V		4.2	22
ON-state				25°C		0.7		
resistance match between channels	$\Delta r_{\sf on}$	$V_{NO}$ or $V_{NC}$ = 0.6 V, 1.5 V, $I_{COM}$ = -2 mA,	Switch ON, See Figure 11	Full	1.8 V	0.7		Ω
		$0 \le V_{NO}$ or $V_{NC} \le V_+$		25°C		1.85		
ON-state	I <sub>COM</sub> = -2 mA Switch ON	Full	4.0.1/	1.85		0		
resistance flatness	r <sub>on(flat)</sub>	$V_{NO} \cup V_{NC} = 0.6 \text{ V}, 1.5 \text{ V},$	See Figure 11	25°C	1.8 V	0.9		Ω
		$I_{COM} = -2 \text{ mA}$		Full		0.9		
NC, NO OFF leakage current	I <sub>NC(OFF)</sub> , I <sub>NO(OFF)</sub>	V <sub>NC</sub> or V <sub>NO</sub> = 1.65 V, V <sub>COM</sub> = 0,	Switch OFF, See Figure 12	25°C	1.95 V	0.2		nA
NC, NO ON leakage current	I <sub>NC(ON)</sub> , I <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = 1.65 \text{ V}$ , $V_{COM} = \text{Open}$ ,	Switch ON, See Figure 13	25°C	1.95 V	2.8		nA
COM ON leakage current	I <sub>COM(ON)</sub>	$V_{NC}$ or $V_{NO}$ = 1.65 V or Open, $V_{COM}$ = 1.65 V,	Switch ON, See Figure 13	25°C	1.95 V	0.47		nA
Digital Control I	nput (IN)							
Input logic high	V <sub>IH</sub>			Full		1.5	5.5	V
Input logic low	V <sub>IL</sub>			Full		0 0.6		V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>I</sub> = 5.5 V or 0		Full	1.95 V	-1	1	μΑ

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 



## **Electrical Characteristics for 1.8-V Supply (continued)**

 $V_{+}$  = 1.65 V to 1.95 V (1.8 V nominal),  $T_{A}$  = -55°C to 125°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CON	DITIONS	T <sub>A</sub>	٧,	MIN TYP(1)	MAX	UNIT
Dynamic	•							
Turn-on time		$V_{COM} = V_+,$	C <sub>L</sub> = 35 pF,	25°C	1.65 V to	65	70	ns
rum-on time	t <sub>ON</sub>	$R_L = 50 \Omega$ ,	See Figure 15	Full	1.95 V		95	115
Turn-off time	t	$V_{COM} = V_+,$	$C_{L} = 35 \text{ pF},$	25°C	1.65 V to	40	55	ns
rum-on ume	t <sub>OFF</sub>	$R_L = 50 \Omega$ ,	See Figure 15	Full	1.95 V		70	113
Break-before-	tonu	$V_{NC} = V_{NO} = V_{+}/2,$	$C_L = 35 pF$ ,	25°C	1.65 V to	1 60	72	ns
make time	t <sub>BBM</sub>	$R_L = 50 \Omega$ ,	See Figure 16	Full	1.95 V	0.5		113
Charge injection	$Q_{C}$	$C_L = 1 \text{ nF},$ $V_{GEN} = 0 \text{ V},$	See Figure 20	25°C	1.8 V	13		pC
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	1.8 V	23		pF
NC, NO ON capacitance	$C_{NC(ON)}, \\ C_{NO(ON)}$	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	1.8 V	84		pF
COM ON capacitance	C <sub>COM(ON)</sub>	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	1.8 V	84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+} \text{ or GND},$	See Figure 14	25°C	1.8 V	2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	1.8 V	100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	1.8 V	-63		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	1.8 V	-63		dB
Supply		-		•	'		,	
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	1.95 V		0.1	μΑ



#### **TYPICAL PERFORMANCE**

1.6

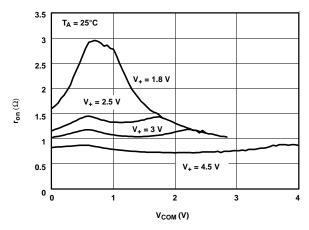
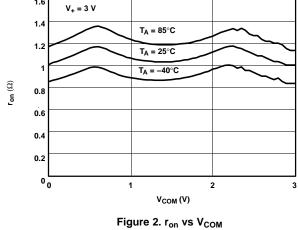


Figure 1. ron vs V<sub>COM</sub>



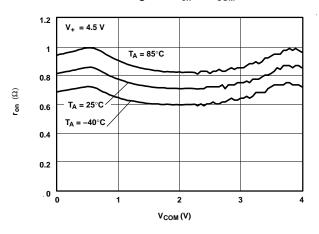


Figure 3. ron vs V<sub>COM</sub>

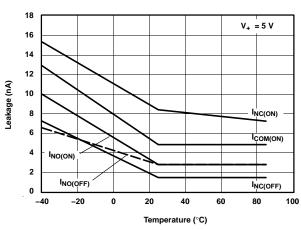


Figure 4. Leakage Current vs Temperature

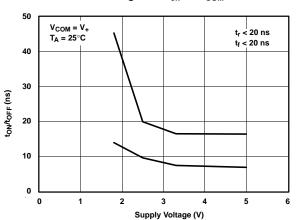


Figure 5. t<sub>ON</sub>/t<sub>OFF</sub> vs V<sub>+</sub>

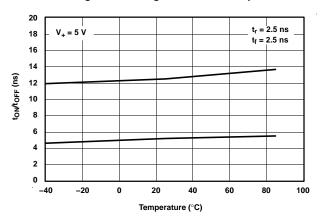
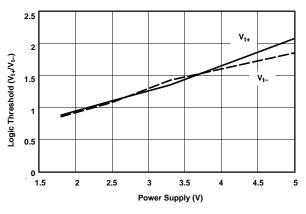


Figure 6. t<sub>ON</sub>/t<sub>OFF</sub> vs Temperature



## **TYPICAL PERFORMANCE (continued)**



-10
-20
-30
-30
-40
-5
-60
-70
-80
-90
0.1
1
10
100
1K

Frequency (MHz)

Figure 7. Logic Threshold vs Power Supply

14 V<sub>+</sub> = 5 V 12 10 Icc (nA) 6 4 2 0 -20 20 40 60 80 100 Temperature (°C)

Figure 8. Frequency Response

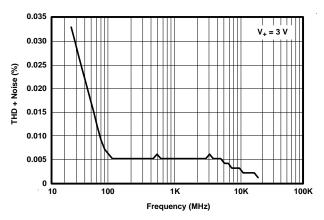


Figure 9. Power-Supply Current vs Temperature

Figure 10. Total Harmonic Distortion (THD) vs Frequency



## **PIN DESCRIPTION**

PIN NO.	NAME	DESCRIPTION					
1	NO	Normally open					
2	GND	Digital ground					
3	NC	Normally closed					
4	COM	Common					
5	V <sub>+</sub>	Power supply					
6	IN	Digital control to connect COM to NO or NC					

#### **PARAMETER DESCRIPTION**

SYMBOL	DESCRIPTION
V <sub>COM</sub>	Voltage at COM
V <sub>NC</sub>	Voltage at NC
V <sub>NO</sub>	Voltage at NO
r <sub>on</sub>	Resistance between COM and NO ports when the channel is ON
r <sub>peak</sub>	Peak on-state resistance over a specified voltage range
$\Delta r_{\sf on}$	Difference of r <sub>on</sub> between channels in a specific device
r <sub>on(flat)</sub>	Difference between the maximum and minimum value of ron in a channel over the specified range of conditions
$I_{NC(OFF)}$	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the OFF state under worst-case input and output conditions
I <sub>NO(OFF)</sub>	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the OFF state
I <sub>NC(ON)</sub>	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the ON state and the output (COM) open
I <sub>NO(ON)</sub>	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the ON state and the output (COM) open
I <sub>COM(ON)</sub>	Leakage current measured at the COM port, with the corresponding channel (COM to NO) in the ON state and the output (NO) open
V <sub>IH</sub>	Minimum input voltage for logic high for the control input (IN)
V <sub>IL</sub>	Maximum input voltage for logic low for the control input (IN)
$V_{IN}$	Voltage at IN
$I_{\rm IH},~I_{\rm IL}$	Leakage current measured at IN
t <sub>ON</sub>	Turn-on time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output (COM or NO) signal when the switch is turning ON.
t <sub>OFF</sub>	Turn-off time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output (COM or NO) signal when the switch is turning OFF.
t <sub>BBM</sub>	Break-before-make time. This parameter is measured under the specified range of conditions and by the propagation delay between the output of two adjacent analog channels (NC and NO), when the control signal changes state.
$Q_{\mathbb{C}}$	Charge injection is a measurement of unwanted signal coupling from the control (IN) input to the analog (NO or COM) output. This is measured in coulomb (C) and measured by the total charge induced due to switching of the control input. Charge injection, $Q_C = C_L \times \Delta V_{COM}$ , $C_L$ is the load capacitance and $\Delta V_{COM}$ is the change in analog output voltage.
C <sub>NC(OFF)</sub>	Capacitance at the NC port when the corresponding channel (NC to COM) is OFF
$C_{NO(OFF)}$	Capacitance at the NO port when the corresponding channel (NO to COM) is OFF
C <sub>NC(ON)</sub>	Capacitance at the NC port when the corresponding channel (NC to COM) is ON
$C_{NO(ON)}$	Capacitance at the NO port when the corresponding channel (NO to COM) is ON
C <sub>COM(ON)</sub>	Capacitance at the COM port when the corresponding channel (COM to NO) is ON
$C_{IN}$	Capacitance of IN
O <sub>ISO</sub>	OFF isolation of the switch is a measurement of OFF-state switch impedance. This is measured in dB in a specific frequency, with the corresponding channel (NO to COM) in the OFF state.
X <sub>TALK</sub>	Crosstalk is a measurement of unwanted signal coupling from an ON channel to an adjacent ON channel (NC1 to NC2). This is measured in a specific frequency and in dB.
BW	Bandwidth of the switch. This is the frequency in which the gain of an ON channel is -3 dB below the DC gain.

# TS5A3159-EP $1-\Omega$ SPDT ANALOG SWITCH

SCDS217B-DECEMBER 2005-REVISED JANUARY 2006



## **PARAMETER DESCRIPTION (continued)**

SYMBOL	DESCRIPTION					
I <sub>+</sub>	I <sub>+</sub> Static power-supply current with the control (IN) pin at V <sub>+</sub> or GND					
$\Delta l_+$	This is the increase in I+ for each control (IN) input that is at the specified voltage, rather than at V+ or GND.					



#### PARAMETER MEASUREMENT INFORMATION

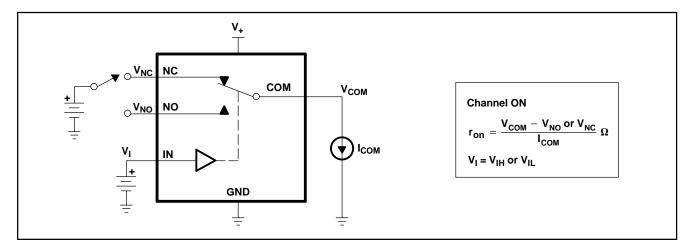


Figure 11. ON-State Resistance (ron)

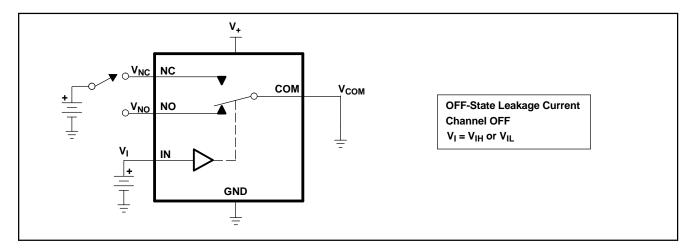


Figure 12. OFF-State Leakage Current ( $I_{NC(OFF)}$ ,  $I_{NO(OFF)}$ )

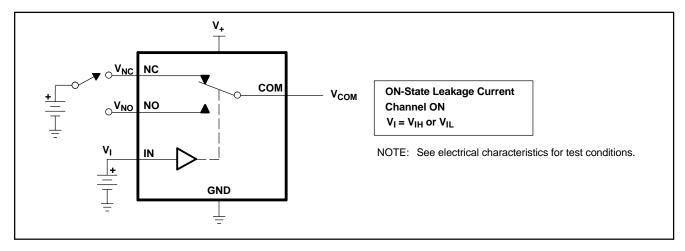


Figure 13. ON-State Leakage Current ( $I_{COM(ON)}$ ,  $I_{NC(ON)}$ ,  $I_{NO(ON)}$ )



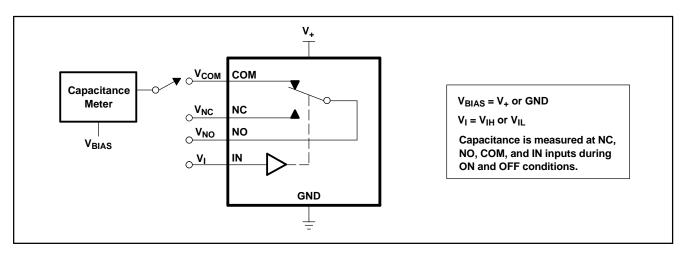
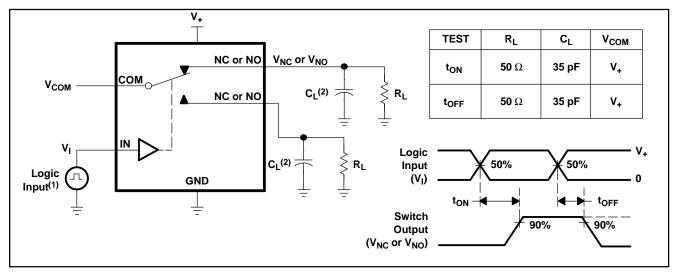


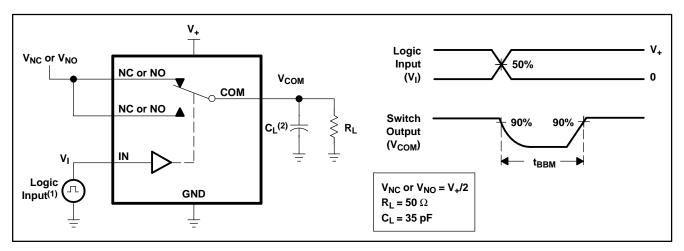
Figure 14. Capacitance (C<sub>I</sub>,  $C_{COM(ON)}$ ,  $C_{NC(OFF)}$ ,  $C_{NO(OFF)}$ ,  $C_{NC(ON)}$ ,  $C_{NO(ON)}$ )



- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 15. Turn-On (t<sub>ON</sub>) and Turn-Off Time (t<sub>OFF</sub>)





- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 16. Break-Before-Make Time (t<sub>BBM</sub>)

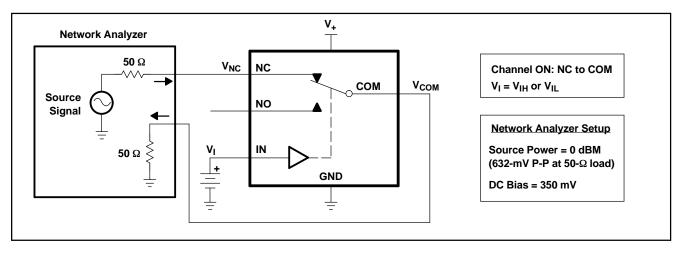


Figure 17. Bandwidth (BW)



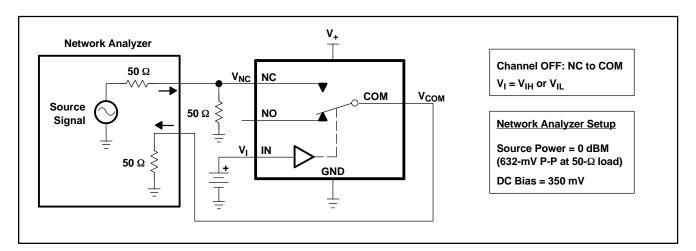


Figure 18. OFF Isolation (O<sub>ISO</sub>)

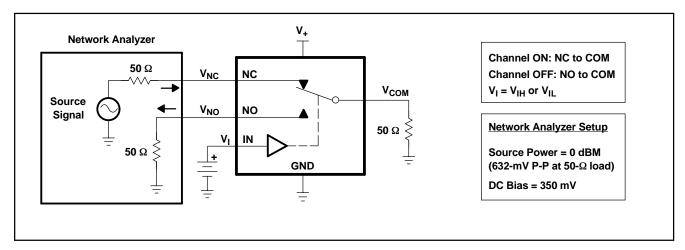
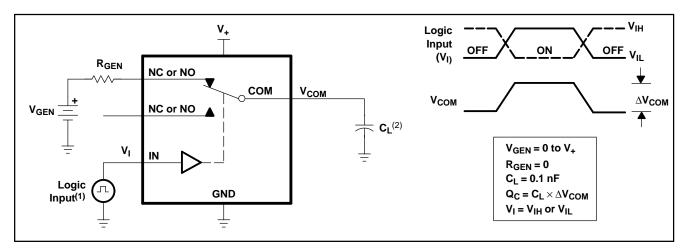


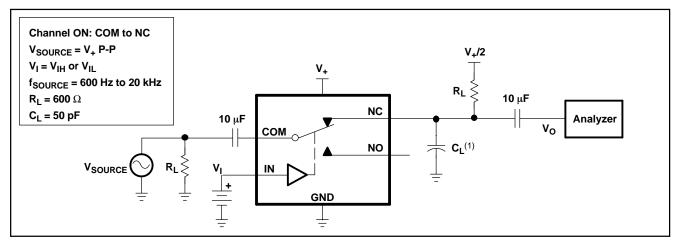
Figure 19. Crosstalk (X<sub>TALK</sub>)





- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 20. Charge Injection (Q<sub>C</sub>)



(1) C<sub>1</sub> includes probe and jig capacitance.

Figure 21. Total Harmonic Distortion (THD)





11-Apr-2013

#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
TS5A3159MDBVREP	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	JA8R	Samples
V62/06613-01XE	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	JA8R	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF TS5A3159-EP:

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.



## **PACKAGE OPTION ADDENDUM**

11-Apr-2013

• Catalog: TS5A3159

www.ti.com

• Automotive: TS5A3159-Q1

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## PACKAGE MATERIALS INFORMATION

www.ti.com 10-Jun-2014

## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS5A3159MDBVREP	SOT-23	DBV	6	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3

www.ti.com 10-Jun-2014



#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS5A3159MDBVREP	SOT-23	DBV	6	3000	202.0	201.0	28.0

# DBV (R-PDSO-G6)

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- Falls within JEDEC MO-178 Variation AB, except minimum lead width.



# DBV (R-PDSO-G6)

## PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



#### IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

#### Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive Communications and Telecom Amplifiers amplifier.ti.com www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps

DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

RFID www.ti-rfid.com

OMAP Applications Processors <u>www.ti.com/omap</u> TI E2E Community <u>e2e.ti.com</u>

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>

# AMEYA360 Components Supply Platform

## **Authorized Distribution Brand:**

























## Website:

Welcome to visit www.ameya360.com

## Contact Us:

## > Address:

401 Building No.5, JiuGe Business Center, Lane 2301, Yishan Rd Minhang District, Shanghai , China

## > Sales:

Direct +86 (21) 6401-6692

Email amall@ameya360.com

QQ 800077892

Skype ameyasales1 ameyasales2

## Customer Service :

Email service@ameya360.com

# Partnership :

Tel +86 (21) 64016692-8333

Email mkt@ameya360.com